

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10586849	MIKI ET AL.
	Examiner	Art Unit
	Thao X Le	2814

SEARCHED

Class	Subclass	Date	Examiner
257	94, 103, 13, 79	10/10/07	TL
257	9,14,94,103	5/14/09	WSL

SEARCH NOTES

Search Notes	Date	Examiner
See search history	10/10/07	TL
quantum well, variable thickness well layer, flat bottom, Group III nitride material	5/14/09	WSL

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
257	9,14,94,103	5/14/09	WSL

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